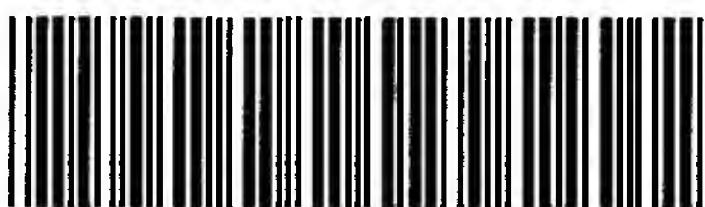


## **Search Notes**



**Application/Control No.**

10/004.805

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**Examiner**

A. Sefer

**Applicant(s)/Patent under  
Reexamination**

SHIMIZU ET AL.

## Art Unit

2826

**SEARCHED**

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

# **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**